

Notice of References Cited

Application/Control No.

10/538,203

Applicant(s)/Patent Under
Reexamination
JUESTEL ET AL.

Examiner

NOAH S. WIESE

Art Unit

4116

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0052595	03-2003	Ellens et al.	313/501
*	B	US-2006/0033081	02-2006	Hintzen et al.	252/301.40F
	C	US-			
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	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.